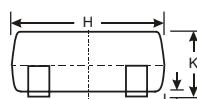
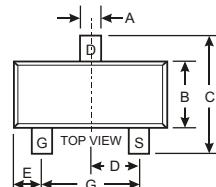


Features

- Super high density cell design for extremely low $R_{DS(ON)}$.
- Fully characterized avalanche voltage and current.
- Excellent package for good heat dissipation.
- We declare that the material of product compliance with RoHS requirements.

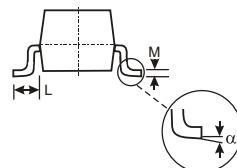


SOT-23		
Dim	Min	Max
A	0.37	0.51
B	1.20	1.40
C	2.30	2.50
D	0.89	1.03
E	0.45	0.60
G	1.78	2.05
H	2.80	3.00
J	0.013	0.10
K	0.903	1.10
L	0.45	0.61
M	0.085	0.180
α	0°	8°

All Dimensions in mm

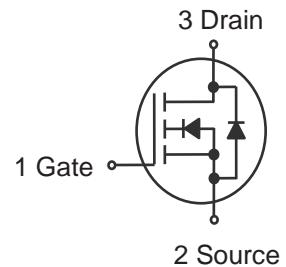
APPLICATIONS

- Power Switching application.
- Hard switchen and high frequency circuits.
- Uninterruptible power supply.
- Marking Code:0102.



Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current	I_D	3.0	A
Peak Drain Current ¹⁾	I_{DM}	20	A
Power Dissipation	P_{tot}	1.5	W
Thermal Resistance from Junction to Ambient (PCB mounted) ²⁾	$R_{\theta JA}$	100	°C/W
Junction Temperature	T_J	175	°C
Storage Temperature Range	T_{stg}	- 55 to + 175	°C



¹⁾ Repetitive Rating: Pulse width limited by the Maximum junction temperation.

²⁾ 1 in² 2oz Cu PCB board.



HAICHUANG SEMI

HC0103

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

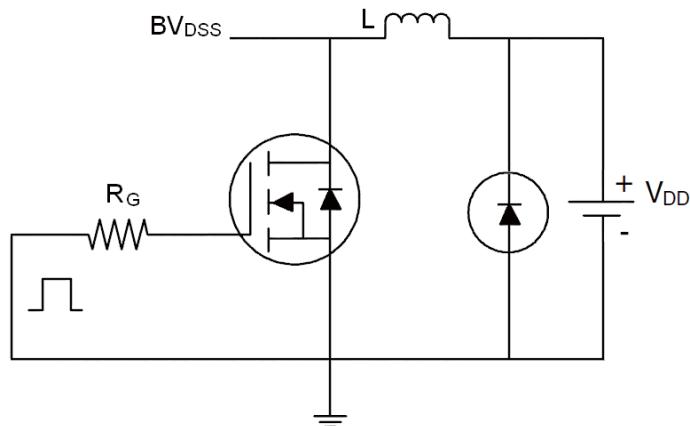
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$		-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$		-	± 100	nA
On Characteristics ^(Note 3)						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.0	1.5	2.0	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=3\text{A}$	-	136	160	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=3\text{A}$	-	140	170	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=2\text{A}$	-	5	-	S
Dynamic Characteristics ^(Note 4)						
Input Capacitance	C_{iss}	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	650	-	PF
Output Capacitance	C_{oss}		-	24	-	PF
Reverse Transfer Capacitance	C_{rss}		-	20	-	PF
Switching Characteristics ^(Note 4)						
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=50\text{V}, R_{\text{L}}=19\Omega$ $V_{\text{GS}}=10\text{V}, R_{\text{G}}=3\Omega$	-	6	-	nS
Turn-on Rise Time	t_{r}		-	4	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	20	-	nS
Turn-Off Fall Time	t_{f}		-	4	-	nS
Total Gate Charge	Q_{g}	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=3\text{A}, V_{\text{GS}}=10\text{V}$	-	20	-	nC
Gate-Source Charge	Q_{gs}		-	2.1	-	nC
Gate-Drain Charge	Q_{gd}		-	3.3	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage ^(Note 3)	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=3\text{A}$	-	-	1.2	V
Diode Forward Current ^(Note 2)	I_{S}		-	-	3	A

Notes:

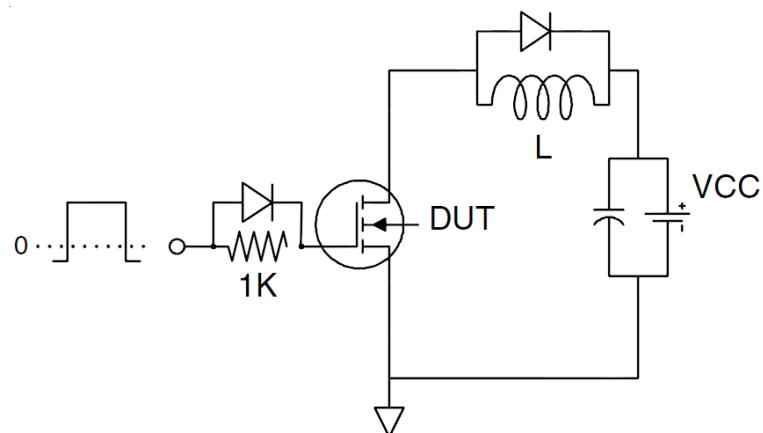
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

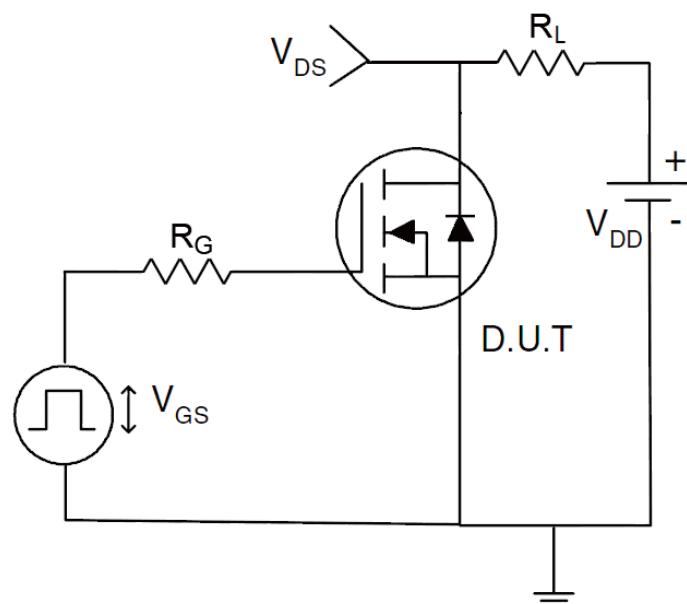
TEST CIRCUIT

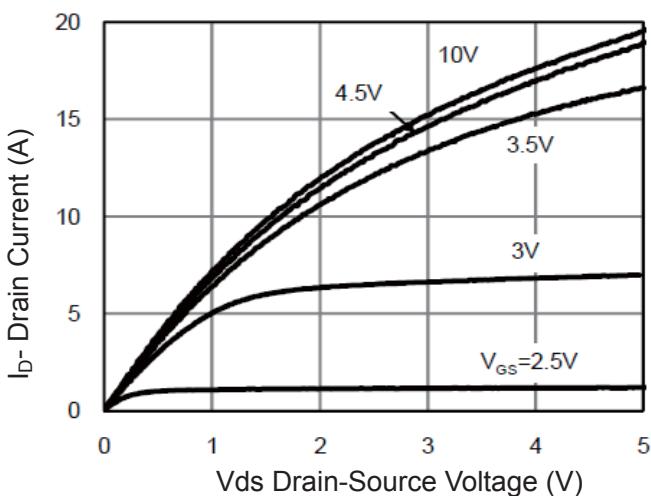
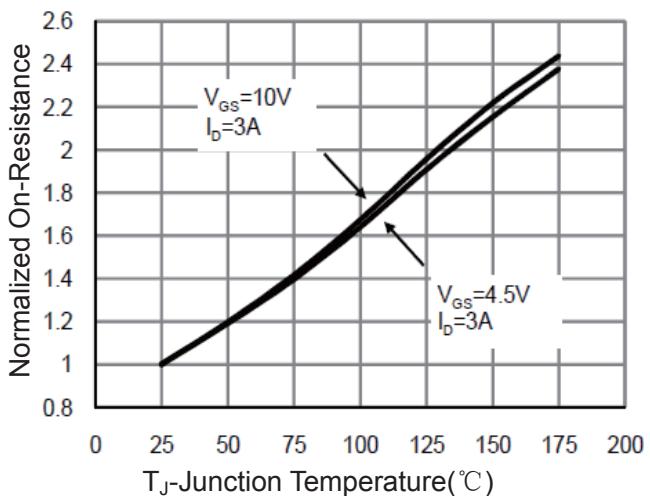
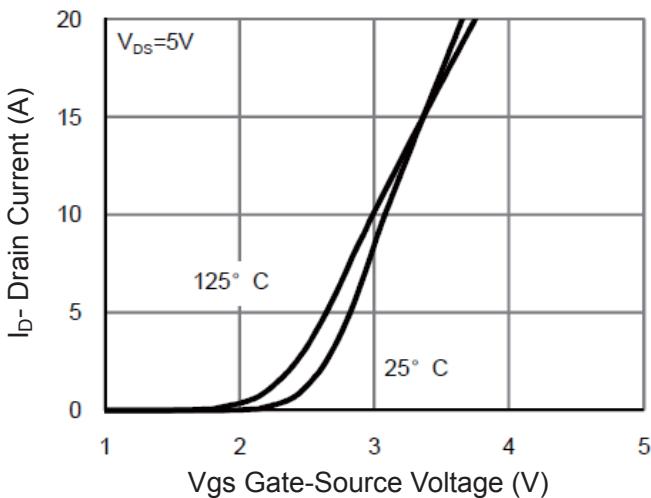
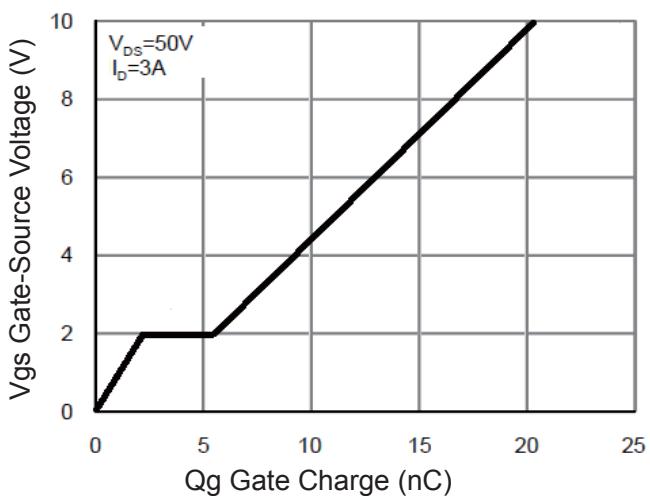
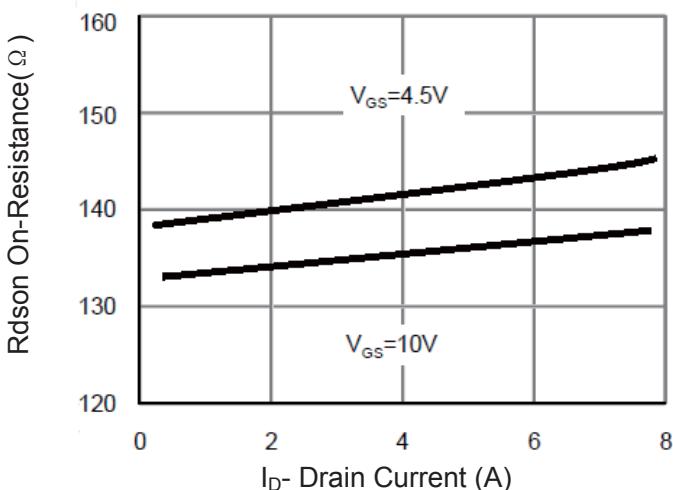
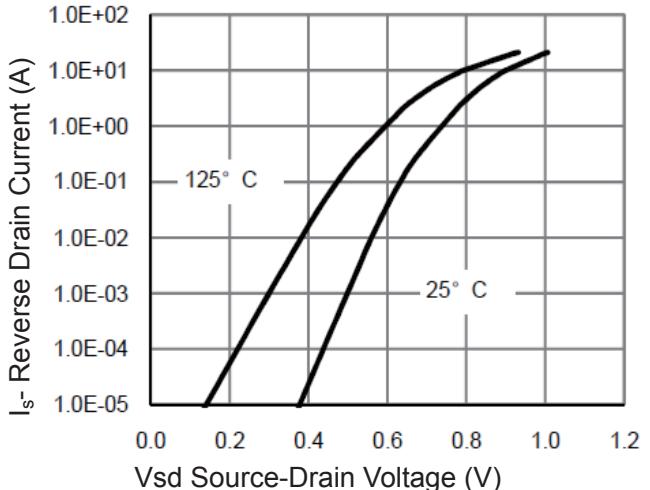
1) E_{AS} test circuit

2) Gate charge test circuit



3) Switch Time Test Circuit



N-CHANNEL ENHANCEMENT MODE POWER MOSFET
TYPICAL TRANSIENT CHARACTERISTICS

Figure 1 Output Characteristics

Figure 4 Rdson-Junction Temperature

Figure 2 Transfer Characteristics

Figure 5 Gate Charge

Figure 3 Rdson- Drain Current

Figure 6 Source- Drain Diode Forward

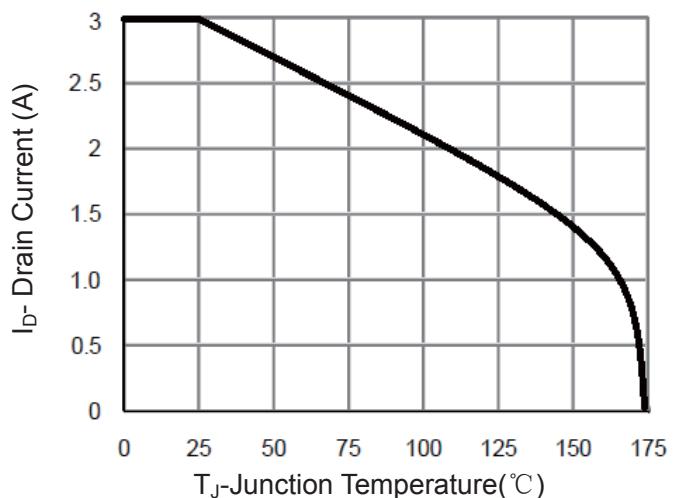
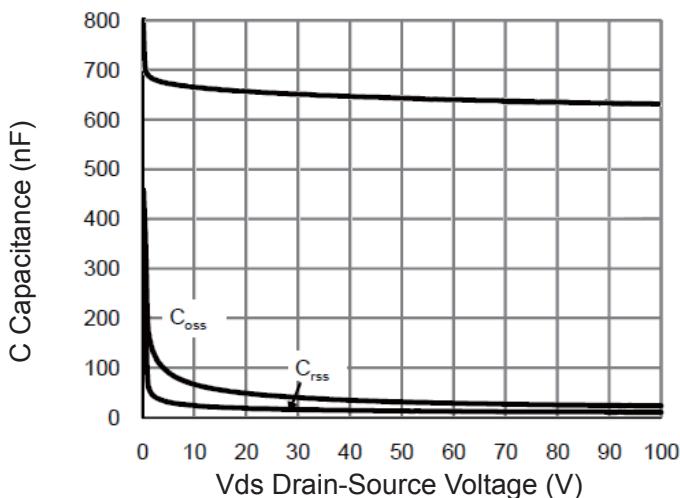
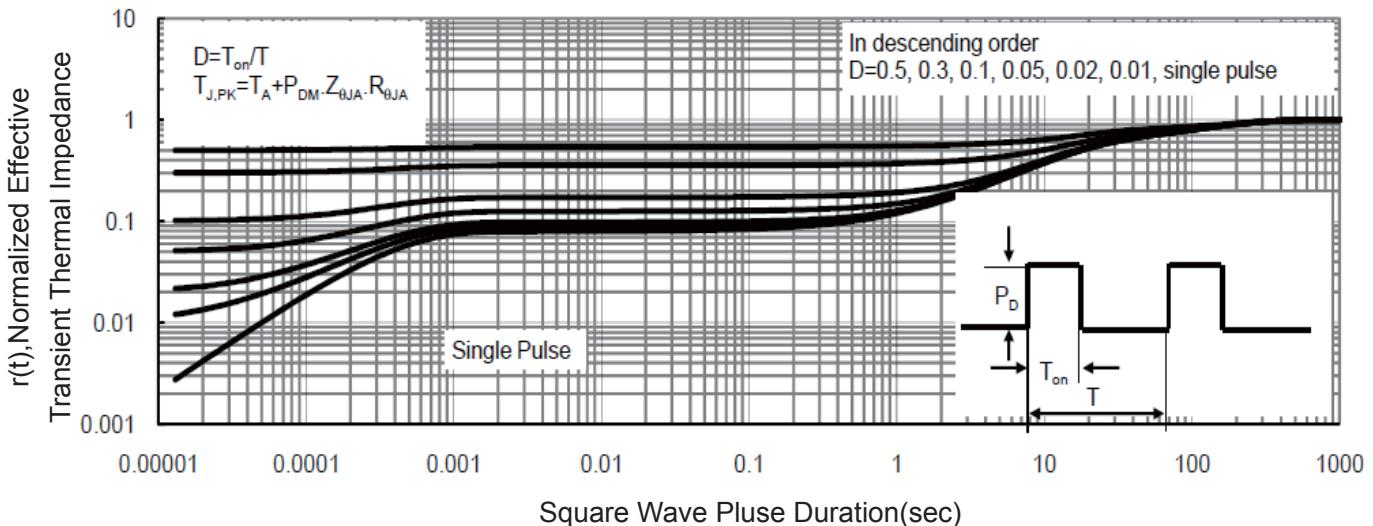
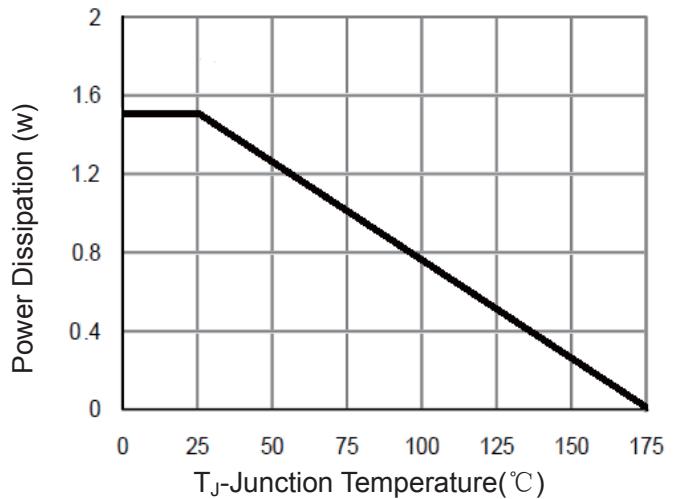
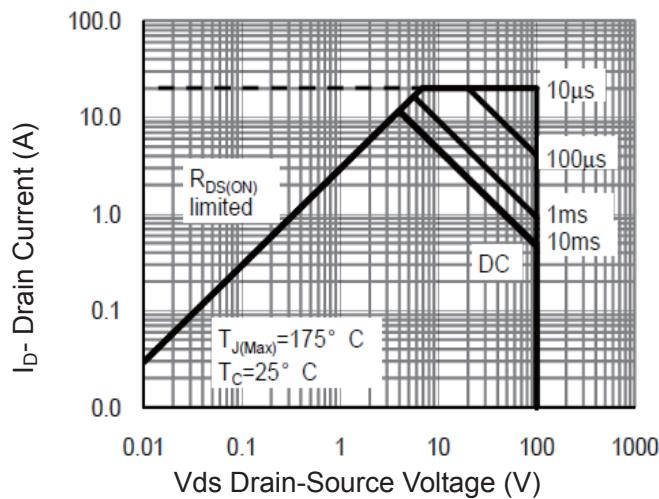
TYPICAL TRANSIENT CHARACTERISTICS


Figure 7 Capacitance vs V_{ds}

Figure 9 BV_{DSS} vs Junction Temperature



IMPORTANT NOTICE

HC-SEMI reserves the right to make changes without further notice to any products herein.

HC-SEMI makes no warranty, representation or guarantee regarding

The suitability of its products for any particular purpose, nor does HC-SEMI assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages.

“Typical” parameters can and do vary in different applications. All operating parameters, including “Typicals” must be validated for each customer application by customer’s technical experts.

HC-SEMI products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the HC-SEMI product could create a situation where personal injury or death may occur.

Should Buyer purchase or use HC-SEMI products for any such unintended or unauthorized application, Buyer shall indemnify and hold HC-SEMI and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that HC-SEMI was negligent regarding the design or manufacture of the part.